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RF EXPOSURE PART 0 TEST REPORT

Applicant Name:

Apple, Inc.
One Apple Park Way
Cupertino, CA 95014

Date of Testing:

10/23/2024 – 11/23/2024

Test Report Issue Date:

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Test Site/Location:

Element, Morgan Hill, CA, USA

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BCGA3267

APPLICANT:

APPLE, INC.

Report Type:

Part 0 SAR Characterization

DUT Type:

Tablet Device

Model(s):

A3267, A3270

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Test results reported herein relate only to the item(s) tested.

RJ Ortanez
Executive Vice President



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1 DEVICE UNDER TEST

1.1 Device Overview

This device uses the Qualcomm® Gen2 Smart Transmit feature to control and manage transmitting power in real time and to ensure the time-averaged RF exposure is in compliance with the FCC requirement at all times for 3G/4G/5G WWAN operations. Additionally, this device supports WLAN/BT/802.15.4/NB-UNII technologies, but the output power of these modems is not controlled by the Smart Transmit algorithm.

Band & Mode	Operating Modes	Tx Frequency
UMTS 850	Data	826.4 - 846.6 MHz
UMTS 1750	Data	1712.4 - 1752.6 MHz
UMTS 1900	Data	1852.4 - 1907.6 MHz
LTE Band 71	Data	665.5 - 695.5 MHz
LTE Band 12	Data	699.7 - 715.3 MHz
LTE Band 17	Data	706.5 - 713.5 MHz
LTE Band 13	Data	779.5 - 784.5 MHz
LTE Band 14	Data	790.5 - 795.5 MHz
LTE Band 26 (Cell)	Data	814.7 - 848.3 MHz
LTE Band 5 (Cell)	Data	824.7 - 848.3 MHz
LTE Band 66 (AWS)	Data	1710.7 - 1779.3 MHz
LTE Band 4 (AWS)	Data	1710.7 - 1754.3 MHz
LTE Band 25 (PCS)	Data	1850.7 - 1914.3 MHz
LTE Band 2 (PCS)	Data	1850.7 - 1909.3 MHz
LTE Band 30	Data	2307.5 - 2312.5 MHz
LTE Band 7	Data	2502.5 - 2567.5 MHz
LTE Band 41	Data	2498.5 - 2687.5 MHz
LTE Band 48	Data	3552.5 - 3697.5 MHz
NR Band n71	Data	665.5 - 695.5 MHz
NR Band n12	Data	701.5 - 713.5 MHz
NR Band n14	Data	790.5 - 795.5 MHz
NR Band n26 (Cell)	Data	816.5 - 846.5 MHz
NR Band n5 (Cell)	Data	826.5 - 846.5 MHz
NR Band n70	Data	1697.5 - 1707.5 MHz
NR Band n66 (AWS)	Data	1712.5 - 1777.5 MHz
NR Band n25 (PCS)	Data	1852.5 - 1912.5 MHz
NR Band n2 (PCS)	Data	1852.5 - 1907.5 MHz
NR Band n30	Data	2307.5 - 2312.5 MHz
NR Band n7	Data	2502.5 - 2567.5 MHz
NR Band n41	Data	2501.01 - 2685.0 MHz
NR Band n48	Data	3555.0 - 3694.98 MHz
NR Band n77 DoD	Data	3455.01 - 3544.98 MHz
NR Band n77 C	Data	3705.0 - 3975.0 MHz
2.4 GHz WLAN	Voice/Data	2412 - 2472 MHz
5 GHz WIFI	Voice/Data	U-NII-1: 5180 - 5240 MHz U-NII-2A: 5260 - 5320 MHz U-NII-2C: 5500 - 5720 MHz U-NII-3: 5745 - 5825 MHz
6 GHz WIFI	Voice/Data	U-NII-5: 5935 - 6415 MHz U-NII-6: 6435 - 6515 MHz U-NII-7: 6535 - 6875 MHz U-NII-8: 6895 - 7115 MHz
Bluetooth	Data	2402 - 2480 MHz
802.15.4	Data	2405 - 2475 MHz
NB UNII-1	Data	5162 - 5245 MHz
NB UNII-3	Data	5733 - 5844 MHz
WPT	N/A	13.56 MHz

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1.2 Time-Averaging for SAR and Power Density

This device is enabled with Qualcomm® Gen2 Smart Transmit algorithm to control and manage transmitting power in real time and to ensure that the time-averaged RF exposure from 3G/4G/5G Sub-6 NR WWAN is in compliance with FCC requirements. This Part 0 report shows SAR characterization of WWAN radios for 3G/4G/5G Sub-6 NR. Characterization is achieved by determining P_{Limit} for 3G/4G/5G Sub-6 NR that corresponds to the exposure design targets after accounting for all device design related uncertainties, i.e., SAR_{design_target} (< FCC SAR limit) for sub-6 radio. The SAR characterization is denoted as SAR Char in this report. Section 1.3 includes a nomenclature of the specific terms used in this report.

The compliance test under the static transmission scenario and simultaneous transmission analysis are reported in Part 1 report. The validation of the time-averaging algorithm and compliance under the dynamic (time- varying) transmission scenario for WWAN technologies are reported in Part 2 report (report SN could be found in Section 1.4 – Bibliography).

1.3 Nomenclature for Part 0 Report

Technology	Term	Description
3G/4G/5G Sub-6 NR	P_{limit}	Power level that corresponds to the exposure design target (SAR_{design_target}) after accounting for all device design related uncertainties
	P_{max}	Maximum tune up output power
	SAR_{design_target}	Target SAR level < FCC SAR limit after accounting for all device design related uncertainties
	SAR_{Char}	Table containing P_{limit} for all technologies and bands

1.4 Bibliography

Report Type	Report Serial Number
FCC SAR Evaluation Report	1C2410210073-02.BCG
RF Exposure Part 2 Test Report	1C2410210073-03.BCG
RF Exposure Compliance Summary	1C2410210073-04.BCG

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2 SAR MEASUREMENTS

2.1 SAR Definition

Specific Absorption Rate is defined as the time derivative (rate) of the incremental energy (dU) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dV) of a given density (ρ). It is also defined as the rate of RF energy absorption per unit mass at a point in an absorbing body (see Equation 2-1).

Equation 2-1
SAR Mathematical Equation

$$SAR = \frac{d}{dt} \left(\frac{dU}{dm} \right) = \frac{d}{dt} \left(\frac{dU}{\rho dv} \right)$$

SAR is expressed in units of Watts per Kilogram (W/kg).

$$SAR = \frac{\sigma \cdot E^2}{\rho}$$

where:

σ	=	conductivity of the tissue-simulating material (S/m)
ρ	=	mass density of the tissue-simulating material (kg/m ³)
E	=	Total RMS electric field strength (V/m)

NOTE: The primary factors that control rate of energy absorption were found to be the wavelength of the incident field in relation to the dimensions and geometry of the irradiated organism, the orientation of the organism in relation to the polarity of field vectors, the presence of reflecting surfaces, and whether conductive contact is made by the organism with a ground plane.[6]

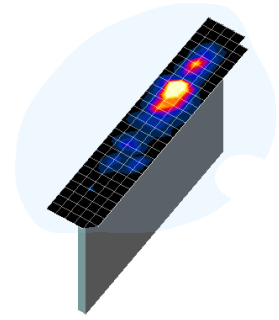
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2.2 SAR Measurement Procedure

The evaluation was performed using the following procedure compliant to FCC KDB Publication 865664 D01v01r04 and IEEE 1528-2013:

1. The SAR distribution at the exposed side of the head or body was measured at a distance no greater than 5.0 mm from the inner surface of the shell. The area covered the entire dimension of the device-head and body interface and the horizontal grid resolution was determined per FCC KDB Publication 865664 D01v01r04 (See Table 2-1) and IEEE 1528-2013.
2. The point SAR measurement was taken at the maximum SAR region determined from Step 1 to enable the monitoring of SAR fluctuations/drifts during the 1g/10g cube evaluation. SAR at this fixed point was measured and used as a reference value.
3. Based on the area scan data, the peak of the region with maximum SAR was determined by spline interpolation. Around this point, a volume was assessed according to the measurement resolution and volume size requirements of FCC KDB Publication 865664 D01v01r04 (See Table 2-1) and IEEE 1528-2013. On the basis of this data set, the spatial peak SAR value was evaluated with the following procedure (see references or the DASY manual online for more details):
 - a. SAR values at the inner surface of the phantom are extrapolated from the measured values along the line away from the surface with spacing no greater than that in Table . The extrapolation was based on a least-squares algorithm. A polynomial of the fourth order was calculated through the points in the z-axis (normal to the phantom shell).
 - b. After the maximum interpolated values were calculated between the points in the cube, the SAR was averaged over the spatial volume (1g or 10g) using a 3D-Spline interpolation algorithm. The 3D-spline is composed of three one-dimensional splines with the “Not a knot” condition (in x, y, and z directions). The volume was then integrated with the trapezoidal algorithm. One thousand points (10 x 10 x 10) were obtained through interpolation, in order to calculate the averaged SAR.
 - c. All neighboring volumes were evaluated until no neighboring volume with a higher average value was found.
4. The SAR reference value, at the same location as step 2, was re-measured after the zoom scan was complete to calculate the SAR drift. If the drift deviated by more than 5%, the SAR test and drift measurements were repeated.



Sample SAR Area Scan

**Table 2-1
Area and Zoom Scan Resolutions per FCC KDB Publication 865664 D01v01r04***

Frequency	Maximum Area Scan Resolution (mm) ($\Delta x_{\text{area}}, \Delta y_{\text{area}}$)	Maximum Zoom Scan Resolution (mm) ($\Delta x_{\text{zoom}}, \Delta y_{\text{zoom}}$)	Maximum Zoom Scan Spatial Resolution (mm)			Minimum Zoom Scan Volume (mm) (x,y,z)
			Uniform Grid	Graded Grid		
				$\Delta z_{\text{zoom}}(n)$	$\Delta z_{\text{zoom}}(1)^*$	
≤ 2 GHz	≤ 15	≤ 8	≤ 5	≤ 4	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 30
2-3 GHz	≤ 12	≤ 5	≤ 5	≤ 4	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 30
3-4 GHz	≤ 12	≤ 5	≤ 4	≤ 3	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 28
4-5 GHz	≤ 10	≤ 4	≤ 3	≤ 2.5	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 25
5-6 GHz	≤ 10	≤ 4	≤ 2	≤ 2	≤ 1.5* $\Delta z_{\text{zoom}}(n-1)$	≥ 22

*Also compliant to IEEE 1528-2013 Table 6

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3 SAR CHARACTERIZATION

3.1 DSI and SAR Determination

This device uses different Device State Index (DSI) to configure different time averaged power levels based on certain exposure scenarios. Depending on the detection scheme implemented in the tablet, the worst-case SAR was determined by measurements for the relevant exposure conditions for that DSI. Detailed descriptions of the detection mechanisms are included in the operational description.

The device state index (DSI) conditions used in Table 3-1 represent different exposure scenarios.

Table 3-1
DSI and Corresponding Exposure Scenarios

Scenario	Description	SAR Test Cases
(DSI = 1)	▪ Device on body	Tablet SAR per KDB Publication 616217 D04

3.2 SAR Design Target

SAR_design_target is determined by ensuring that it is less than FCC SAR limit after accounting for uncertainties specified by the manufacturer (see Table 3-2).

Table 3-2
***SAR_design_target* Calculations**

1g SAR (W/kg)			
Mode/Band/Antenna	Smart Tx Uncertainty	<i>SAR_design_target</i>	<i>SAR_regulatory_limit</i>
UMTS 850 Ant 3b	0.7 dB	0.86 W/kg	1.6 W/kg
LTE Band 71 Ant 3b	0.7 dB	0.86 W/kg	
LTE Band 12 Ant 3b	0.7 dB	0.86 W/kg	
LTE Band 17 Ant 3b	0.7 dB	0.86 W/kg	
LTE Band 13 Ant 3b	0.7 dB	0.86 W/kg	
LTE Band 14 Ant 3b	0.7 dB	0.86 W/kg	
LTE Band 26 Ant 3b	0.7 dB	0.86 W/kg	
LTE Band 5 Ant 3b	0.7 dB	0.86 W/kg	
NR Band 71 Ant 3b	0.7 dB	0.86 W/kg	
NR Band 12 Ant 3b	0.7 dB	0.86 W/kg	
NR Band 14 Ant 3b	0.7 dB	0.86 W/kg	
NR Band 26 Ant 3b	0.7 dB	0.86 W/kg	
NR Band 5 Ant 3b	0.7 dB	0.86 W/kg	
UMTS 850 Ant 4	0.7 dB	0.86 W/kg	
LTE Band 12 Ant 4	0.7 dB	0.86 W/kg	
LTE Band 17 Ant 4	0.7 dB	0.86 W/kg	
LTE Band 26 Ant 4	0.7 dB	0.86 W/kg	
LTE Band 5 Ant 4	0.7 dB	0.86 W/kg	
NR Band 12 Ant 4	0.7 dB	0.86 W/kg	
NR Band 26 Ant 4	0.7 dB	0.86 W/kg	
NR Band 5 Ant 4	0.7 dB	0.86 W/kg	
All other modes/bands/antennas	1.0 dB	0.80 W/kg	

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3.3 SAR Char

SAR test results corresponding to P_{max} for each antenna/technology/band/DSI can be found in FCC SAR Part 1 Report.

P_{limit} is calculated by linearly scaling with the measured SAR at the P_{part0} to correspond to the SAR_{design_target} . When $P_{limit} < P_{max}$, P_{part0} was used as P_{limit} in the Smart Transmit EFS. When $P_{limit} > P_{max}$ and $P_{part0}=P_{max}$, calculated P_{limit} was used in the Smart Transmit EFS. All reported SAR obtained from the P_{part0} SAR tests was less than $SAR_{Design_target} + \text{Uncertainty}$. The final P_{limit} determination for each exposure scenario corresponding to SAR_{design_target} are shown in Table 3-3.

Table 3-3
 P_{Limit} Determination

Device State Index (DSI)	P_{Limit} Determination Scenarios
1	The worst-case SAR exposure is determined as maximum SAR normalized to the limit among: 1. Tablet SAR measured at 0 mm for Back, Top, Bottom, Right, Left surfaces

Note:

For DSI = 1, P_{limit} is calculated by:

P_{limit} corresponding to 1g Tablet SAR evaluation at 0 mm for back, top, bottom, left and right surfaces

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Table 3-4
SAR Characterizations

Exposure Scenario:	Ant 1a	Ant 1a	Ant 1b	Ant 1b	Ant 2a	Ant 2a	Ant 2b	Ant 2b	Ant 3a	Ant 3a	Ant 3b	Ant 3b	Ant 4	Ant 4
Averaging Volume:	1g	Maximum Tune-up	1g	Maximum Tune-up	1g	Maximum Tune-up	1g	Maximum Tune-up	1g	Maximum Tune-up	1g	Maximum Tune-up	1g	Maximum Tune-up
Slicing:	0 mm	Output Power*	0 mm	Output Power*	0 mm	Output Power*	0 mm	Output Power*	0 mm	Output Power*	0 mm	Output Power*	0 mm	Output Power*
DSE:	1		1		1		1		1		1		1	
Technology/Band	Plimit corresponding to SAR design target	Pmax	Plimit corresponding to SAR design target	Pmax	Plimit corresponding to SAR design target	Pmax	Plimit corresponding to SAR design target	Pmax	Plimit corresponding to SAR design target	Pmax	Plimit corresponding to SAR design target	Pmax	Plimit corresponding to SAR design target	Pmax
UMTS 850	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.40	24.50	18.00	25.00
UMTS 1700	N/A	N/A	11.30	23.00	N/A	N/A	12.50	23.50	12.80	24.00	N/A	N/A	14.20	25.00
UMTS 1900	N/A	N/A	11.80	23.00	N/A	N/A	12.90	23.50	13.80	24.00	N/A	N/A	13.80	25.00
LTE Band 71	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	18.00	24.50	20.30	25.00
LTE Band 12	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	17.10	24.50	18.70	25.00
LTE Band 17	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	17.10	24.50	18.70	25.00
LTE Band 13	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.50	24.50	18.20	25.00
LTE Band 14	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.50	24.50	18.20	25.00
LTE Band 26	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.40	24.50	18.00	25.00
LTE Band 5	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.00	24.50	18.00	25.00
LTE Band 5 ULCA	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.00	24.50	18.00	25.00
LTE Band 4	N/A	N/A	12.10	24.00	N/A	N/A	12.50	25.00	12.80	24.00	N/A	N/A	14.20	25.00
LTE Band 66	N/A	N/A	12.10	24.00	N/A	N/A	12.50	25.00	12.80	24.00	N/A	N/A	14.20	25.00
LTE Band 2	N/A	N/A	11.80	23.00	N/A	N/A	12.90	23.50	13.80	24.00	N/A	N/A	13.80	25.00
LTE Band 25	N/A	N/A	11.80	23.00	N/A	N/A	12.90	23.50	13.80	24.00	N/A	N/A	13.80	25.00
LTE Band 30	N/A	N/A	12.60	22.50	N/A	N/A	13.20	23.50	10.90	19.80	N/A	N/A	10.80	21.00
LTE Band 7	N/A	N/A	12.50	22.50	N/A	N/A	13.20	23.50	10.30	24.00	N/A	N/A	11.40	25.00
LTE Band 7 ULCA	N/A	N/A	12.50	22.50	N/A	N/A	13.20	23.50	10.30	24.00	N/A	N/A	11.40	25.00
LTE Band 41 (PC3)	N/A	N/A	12.7	23.0	N/A	N/A	13.3	23.0	10.8	23.0	N/A	N/A	11.9	23.0
LTE Band 41 (PC3) ULCA	N/A	N/A	12.7	23.0	N/A	N/A	13.3	23.0	10.8	23.0	N/A	N/A	11.9	23.0
LTE Band 41 (PC3)	N/A	N/A	12.7	22.9	N/A	N/A	13.3	24.4	10.8	22.4	N/A	N/A	11.9	23.4
LTE Band 41 (PC3) ULCA	N/A	N/A	12.7	22.9	N/A	N/A	13.3	24.4	10.8	22.4	N/A	N/A	11.9	23.4
LTE Band 48	10.5	19.5	N/A	N/A	8.0	16.9	N/A	N/A	N/A	N/A	11.9	16.2	11.5	20.0
LTE Band 48 ULCA	10.5	19.5	N/A	N/A	8.0	16.9	N/A	N/A	N/A	N/A	11.9	16.2	11.5	20.0
NR Band n71	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	17.40	24.50	20.80	25.00
NR Band n12	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	17.10	24.50	18.70	25.00
NR Band n14	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.50	24.50	18.20	25.00
NR Band n26	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.00	24.50	18.00	25.00
NR Band n25	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	16.00	24.50	18.00	25.00
NR Band n20	N/A	N/A	11.30	24.00	N/A	N/A	12.50	25.00	12.80	24.00	N/A	N/A	14.20	25.00
NR Band n66	N/A	N/A	11.30	24.00	N/A	N/A	12.50	25.00	12.80	24.00	N/A	N/A	14.20	25.00
NR Band n2	N/A	N/A	11.80	23.00	N/A	N/A	12.90	23.50	13.80	24.00	N/A	N/A	13.80	25.00
NR Band n25	N/A	N/A	11.80	23.00	N/A	N/A	12.90	23.50	13.80	24.00	N/A	N/A	13.80	25.00
NR Band n30	N/A	N/A	12.60	22.50	N/A	N/A	13.20	23.50	10.90	19.80	N/A	N/A	10.80	21.00
NR Band n7	N/A	N/A	12.50	22.50	N/A	N/A	13.20	23.50	10.30	24.00	N/A	N/A	11.40	25.00
NR Band n41 (PC3)	N/A	N/A	12.20	25.00	N/A	N/A	12.80	25.00	11.00	25.00	N/A	N/A	11.40	25.00
NR Band n41 (PC2)	N/A	N/A	12.20	26.50	N/A	N/A	12.80	28.00	11.00	26.00	N/A	N/A	11.40	27.00
NR Band n77 (PC3)	8.50	22.50	N/A	N/A	7.20	22.50	N/A	N/A	N/A	N/A	10.80	24.70	8.80	24.70
NR Band n77 (PC1)	8.50	22.50	N/A	N/A	7.20	22.50	N/A	N/A	N/A	N/A	10.90	25.00	8.80	25.50
NR Band n48	8.60	21.50	N/A	N/A	8.10	18.90	N/A	N/A	N/A	N/A	11.30	18.20	11.30	22.00

Notes:

- *Maximum tune up output power Pmax is used to configure EUT during RF tune up procedure. The maximum allowed output power is equal to maximum Tune up output power +0.7/-1.0 dB conducted power tolerance and +1.0/-1.0 dB conducted power tolerance for UHB.
- All P_{limit} EFS and maximum tune up output power P_{max} levels entered in above Table correspond to average power levels after accounting for duty cycle in the case of TDD modulation schemes (for e.g., LTE TDD).

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13 EQUIPMENT LIST

For SAR measurements

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	E4404B	Spectrum Analyzer	N/A	N/A	N/A	MY45113242
Agilent	E4438C	ESG Vector Signal Generator	10/23/2024	Annual	10/23/2025	MY45093852
Agilent	E4438C	ESG Vector Signal Generator	3/25/2024	Annual	3/25/2025	MY47270002
Agilent	N5182A	MVG Vector Signal Generator	7/9/2024	Annual	7/9/2025	MY48180366
Agilent	N5182A	MVG Vector Signal Generator	3/7/2024	Annual	3/7/2025	MY47420603
Agilent	8753ES	S-Parameter Vector Network Analyzer	1/10/2024	Annual	1/10/2025	MY40001472
Agilent	8753ES	S-Parameter Vector Network Analyzer	9/25/2024	Annual	9/25/2025	MY40003841
Agilent	E5515C	Wireless Communications Test Set	CBT	N/A	CBT	GB46310798
Agilent	E5515C	Wireless Communications Test Set	CBT	N/A	CBT	US41140256
Agilent	N4010A	Wireless Connectivity Test Set	N/A	N/A	N/A	GB46170464
Amplifier Research	1551G6	Amplifier	CBT	N/A	CBT	433973
Amplifier Research	1551G6	Amplifier	CBT	N/A	CBT	433974
Amplifier Research	150A100C	Amplifier	CBT	N/A	CBT	350132
Anritsu	MNA128B	I/O Adapter	CBT	N/A	CBT	6261747881
Anritsu	ML2496A	Power Meter	7/15/2024	Annual	7/15/2025	11389012
Anritsu	ML2496A	Power Meter	6/24/2024	Annual	6/24/2025	1840005
Anritsu	MA2411B	Pulse Power Sensor	9/5/2024	Annual	9/5/2025	1726262
Anritsu	MA2411B	Pulse Power Sensor	10/21/2024	Annual	10/21/2025	1027293
Anritsu	MT8821C	Radio Communication Analyzer MT8821C	12/15/2023	Annual	12/15/2024	6200901190
Anritsu	MT8821C	Radio Communication Analyzer MT8821C	5/15/2024	Annual	5/15/2025	6262150047
Anritsu	MT8821C	Radio Communication Analyzer MT8821C	4/23/2024	Annual	4/23/2025	6272337439
Anritsu	MT8821C	Radio Communication Analyzer MT8821C	5/14/2024	Annual	5/14/2025	6272337439
Anritsu	MA24106A	USB Power Sensor	7/10/2024	Annual	7/10/2025	1827530
Anritsu	MA24106A	USB Power Sensor	12/4/2023	Annual	12/4/2024	1520501
Control Company	4052	Long Stem Thermometer	2/27/2024	Biennial	2/27/2026	240174346
Control Company	4052	Long Stem Thermometer	2/27/2024	Biennial	2/27/2026	240171096
Control Company	4040	Therm./Clock/Humidity Monitor	4/15/2024	Biennial	4/15/2026	240310280
Control Company	4040	Therm./Clock/Humidity Monitor	4/15/2024	Biennial	4/15/2026	240310280
Mitsutoyo	500-196-30	CO-5/45M Sixch Digital Caliper	2/16/2022	Annual	2/16/2025	420238413
Keysight Technologies	N9202A	MXA Signal Analyzer	7/8/2024	Annual	7/8/2025	MY48010233
Agilent	N9202A	MXA Signal Analyzer	6/14/2024	Annual	6/14/2025	MY56470202
MCCL	BW-N6W5+	60B Attenuator	CBT	N/A	CBT	1139
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	VLF-6000+	Low Pass Filter DC to 6000 MHz	7/10/2024	Annual	7/10/2025	31634
Mini-Circuits	BW-N20W5+	DC to 18 GHz Precision Fixed 20 dB Attenuator	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1200 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2950 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	BW-N20W5	Power Attenuator	CBT	N/A	CBT	1226
Mini-Circuits	ZUDC10-83-5+	Directional Coupler	CBT	N/A	CBT	2050
Narda	4772-3	Attenuator (3dB)	CBT	N/A	CBT	9406
Narda	BW-53W2	Attenuator (3dB)	CBT	N/A	CBT	120
Seelionk	NC-100	Torque Wrench	CBT	N/A	CBT	22217
Seelionk	NC-100	Torque Wrench	4/2/2024	Biennial	4/2/2026	1262
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	1/10/2024	Annual	1/10/2025	131453
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	7/8/2024	Annual	7/8/2025	166818
SPEAG	DAK-3.5	Dielectric Assessment Kit	11/5/2024	Annual	11/5/2025	1277
SPEAG	DAK-3.5	Portable Dielectric Assessment Kit	8/7/2024	Annual	8/7/2025	1041
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1237
SPEAG	MAIA	Modulation and Audio Interference Analyzer	N/A	N/A	N/A	1331
SPEAG	DAK-12	Dielectric Assessment Kit (1MHz - 30GHz)	3/1/2024	Annual	3/1/2025	1102
SPEAG	5G Verification Source 100Hz	100Hz System Verification Antenna	8/6/2024	Annual	8/6/2025	1004
SPEAG	D1750V2	1750 MHz SAR Dipole	9/6/2023	Biennial	9/6/2025	1104
SPEAG	D1750V2	1750 MHz SAR Dipole	5/10/2022	Triennial	5/10/2025	1083
SPEAG	D1900V2	1900 MHz SAR Dipole	9/7/2023	Biennial	9/7/2025	5d181
SPEAG	D2300V2	2300 MHz SAR Dipole	3/11/2024	Annual	3/11/2025	1038
SPEAG	D2450V2	2450 MHz SAR Dipole	5/11/2022	Triennial	5/11/2025	750
SPEAG	D2450V2	2450 MHz SAR Dipole	11/15/2023	Triennial	11/15/2025	855
SPEAG	D2600V2	2600 MHz SAR Dipole	5/11/2022	Triennial	5/11/2025	1042
SPEAG	D3500V2	3500 MHz SAR Dipole	6/10/2024	Annual	6/10/2025	1126
SPEAG	D3700V2	3700 MHz SAR Dipole	6/10/2024	Annual	6/10/2025	1097
SPEAG	D3900V2	3900 MHz SAR Dipole	12/21/2023	Annual	12/21/2024	1062
SPEAG	D50GHV2	5 GHz SAR Dipole	6/12/2024	Annual	6/12/2025	1163
SPEAG	D6.5GHV2	6.5 GHz SAR Dipole	10/10/2024	Annual	10/10/2025	1019
SPEAG	D750V1	750 MHz SAR Dipole	9/13/2023	Biennial	9/13/2025	1097
SPEAG	D750V1	750 MHz SAR Dipole	5/16/2022	Triennial	5/16/2025	1057
SPEAG	D835V2	835 MHz SAR Dipole	5/16/2022	Triennial	5/16/2025	460
SPEAG	CLA13	Confined Loop Antenna	11/11/2024	Annual	11/11/2025	1004
SPEAG	DAE4	Daisy Data Acquisition Electronics	4/9/2024	Annual	4/9/2025	501
SPEAG	DAE4	Daisy Data Acquisition Electronics	3/6/2024	Annual	3/6/2025	604
SPEAG	DAE4	Daisy Data Acquisition Electronics	8/4/2024	Annual	8/4/2025	1684
SPEAG	DAE4	Daisy Data Acquisition Electronics	8/8/2024	Annual	8/8/2025	1681
SPEAG	DAE4	Daisy Data Acquisition Electronics	9/4/2024	Annual	9/4/2025	1403
SPEAG	DAE4	Daisy Data Acquisition Electronics	5/8/2024	Annual	5/8/2025	701
SPEAG	DAE4	Daisy Data Acquisition Electronics	4/10/2024	Annual	4/10/2025	1402
SPEAG	DAE4	Daisy Data Acquisition Electronics	5/8/2024	Annual	5/8/2025	1683
SPEAG	DAE4	Daisy Data Acquisition Electronics	9/3/2024	Annual	9/3/2025	1646
SPEAG	DAE4	Daisy Data Acquisition Electronics	4/9/2024	Annual	4/9/2025	1582
SPEAG	DAE4	Daisy Data Acquisition Electronics	5/8/2024	Annual	5/8/2025	1676
SPEAG	DAE4	Daisy Data Acquisition Electronics	2/9/2024	Annual	2/9/2025	467
SPEAG	DAE4	Daisy Data Acquisition Electronics	10/9/2024	Annual	10/9/2025	1333
SPEAG	EX3DV4	SAR Probe	9/9/2024	Annual	9/9/2025	7639
SPEAG	EX3DV4	SAR Probe	3/11/2024	Annual	3/11/2025	7421
SPEAG	EX3DV4	SAR Probe	5/13/2024	Annual	5/13/2025	7882
SPEAG	EX3DV4	SAR Probe	8/9/2024	Annual	8/9/2025	3940
SPEAG	EX3DV4	SAR Probe	4/16/2024	Annual	4/16/2025	7357
SPEAG	EX3DV4	SAR Probe	4/16/2024	Annual	4/16/2025	7546
SPEAG	EX3DV4	SAR Probe	5/13/2024	Annual	5/13/2025	7552
SPEAG	EX3DV4	SAR Probe	9/4/2024	Annual	9/4/2025	7668
SPEAG	EX3DV4	SAR Probe	2/9/2024	Annual	2/9/2025	7427
SPEAG	EX3DV4	SAR Probe	5/13/2024	Annual	5/13/2025	7416
SPEAG	EX3DV4	SAR Probe	4/16/2024	Annual	4/16/2025	7532
SPEAG	EX3DV4	SAR Probe	9/13/2024	Annual	9/13/2025	7782
SPEAG	EUMMW4	EUMMW4 Probe	4/8/2024	Annual	4/8/2025	9487

Note:

1. CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, amplifier, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.
2. Each equipment item was used solely within its respective calibration period.

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14 MEASUREMENT UNCERTAINTIES

Applicable for SAR measurements < 6 GHz:

a	b	c	d	e= f(d,k)	f	g	h = c x f/e	i = c x g/e	k
Uncertainty Component	IEEE 1528 Sec.	Tol. (± %)	Prob. Dist.	Div.	c _i 1gm	c _i 10 gms	1gm u _i (± %)	10gms u _i (± %)	v _i
Measurement System									
Probe Calibration	E2.1	7	N	1	1	1	7.0	7.0	∞
Axial Isotropy	E2.2	0.25	N	1	0.7	0.7	0.2	0.2	∞
Hemishperical Isotropy	E2.2	1.3	N	1	0.7	0.7	0.9	0.9	∞
Boundary Effect	E2.3	2	R	1.732	1	1	1.2	1.2	∞
Linearity	E2.4	0.3	N	1	1	1	0.3	0.3	∞
System Detection Limits	E2.4	0.25	R	1.732	1	1	0.1	0.1	∞
Modulation Response	E2.5	4.8	R	1.732	1	1	2.8	2.8	∞
Readout Electronics	E2.6	0.3	N	1	1	1	0.3	0.3	∞
Response Time	E2.7	0.8	R	1.732	1	1	0.5	0.5	∞
Integration Time	E2.8	2.6	R	1.732	1	1	1.5	1.5	∞
RF Ambient Conditions - Noise	E6.1	3	R	1.732	1	1	1.7	1.7	∞
RF Ambient Conditions - Reflections	E6.1	3	R	1.732	1	1	1.7	1.7	∞
Probe Positioner Mechanical Tolerance	E6.2	0.8	R	1.732	1	1	0.5	0.5	∞
Probe Positioning w/ respect to Phantom	E6.3	6.7	R	1.732	1	1	3.9	3.9	∞
Extrapolation, Interpolation & Integration algorithms for Max. SAR Evaluation	E5	4	R	1.732	1	1	2.3	2.3	∞
Test Sample Related									
Test Sample Positioning	E4.2	3.12	N	1	1	1	3.1	3.1	35
Device Holder Uncertainty	E4.1	1.67	N	1	1	1	1.7	1.7	5
Output Power Variation - SAR drift measurement	E2.9	5	R	1.732	1	1	2.9	2.9	∞
SAR Scaling	E6.5	0	R	1.732	1	1	0.0	0.0	∞
Phantom & Tissue Parameters									
Phantom Uncertainty (Shape & Thickness tolerances)	E3.1	7.6	R	1.73	1.0	1.0	4.4	4.4	∞
Liquid Conductivity - measurement uncertainty	E3.3	4.3	N	1	0.78	0.71	3.3	3.0	76
Liquid Permittivity - measurement uncertainty	E3.3	4.2	N	1	0.23	0.26	1.0	1.1	75
Liquid Conductivity - Temperature Uncertainty	E3.4	3.4	R	1.732	0.78	0.71	1.5	1.4	∞
Liquid Permittivity - Temperature Uncertainty	E3.4	0.6	R	1.732	0.23	0.26	0.1	0.1	∞
Liquid Conductivity - deviation from target values	E3.2	5.0	R	1.73	0.64	0.43	1.8	1.2	∞
Liquid Permittivity - deviation from target values	E3.2	5.0	R	1.73	0.60	0.49	1.7	1.4	∞
Combined Standard Uncertainty (k=1)	RSS						12.2	12.0	191
Expanded Uncertainty (95% CONFIDENCE LEVEL)	k=2						24.4	24.0	

The above measurement uncertainties are according to IEEE Std. 1528-2013

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Applicable for SAR measurements > 6 GHz:

a	b	c	d	e= f(d,k)	f	g	h = c x f/e	i = c x g/e	k
Uncertainty Component	IEEE 1528 Sec.	Tol. (± %)	Prob. Dist.	Div.	c _i 1gm	c _i 10 gms	1gm u _i (± %)	10gms u _i (± %)	v _i
Measurement System									
Probe Calibration	E2.1	9.3	N	1	1	1	9.3	9.3	∞
Axial Isotropy	E2.2	0.25	N	1	0.7	0.7	0.2	0.2	∞
Hemishperical Isotropy	E2.2	1.3	N	1	0.7	0.7	0.9	0.9	∞
Boundary Effect	E2.3	2	R	1.732	1	1	1.2	1.2	∞
Linearity	E2.4	0.3	N	1	1	1	0.3	0.3	∞
System Detection Limits	E2.4	0.25	R	1.732	1	1	0.1	0.1	∞
Modulation Response	E2.5	4.8	R	1.732	1	1	2.8	2.8	∞
Readout Electronics	E2.6	0.3	N	1	1	1	0.3	0.3	∞
Response Time	E2.7	0.8	R	1.732	1	1	0.5	0.5	∞
Integration Time	E2.8	2.6	R	1.732	1	1	1.5	1.5	∞
RF Ambient Conditions - Noise	E6.1	3	R	1.732	1	1	1.7	1.7	∞
RF Ambient Conditions - Reflections	E6.1	3	R	1.732	1	1	1.7	1.7	∞
Probe Positioner Mechanical Tolerance	E6.2	0.8	R	1.732	1	1	0.5	0.5	∞
Probe Positioning w/ respect to Phantom	E6.3	6.7	R	1.732	1	1	3.9	3.9	∞
Extrapolation, Interpolation & Integration algorithms for Max. SAR Evaluation	E5	4	R	1.732	1	1	2.3	2.3	∞
Test Sample Related									
Test Sample Positioning	E4.2	3.12	N	1	1	1	3.1	3.1	35
Device Holder Uncertainty	E4.1	1.67	N	1	1	1	1.7	1.7	5
Output Power Variation - SAR drift measurement	E2.9	5	R	1.732	1	1	2.9	2.9	∞
SAR Scaling	E6.5	0	R	1.732	1	1	0.0	0.0	∞
Phantom & Tissue Parameters									
Phantom Uncertainty (Shape & Thickness tolerances)	E3.1	7.6	R	1.73	1.0	1.0	4.4	4.4	∞
Liquid Conductivity - measurement uncertainty	E3.3	4.3	N	1	0.78	0.71	3.3	3.0	76
Liquid Permittivity - measurement uncertainty	E3.3	4.2	N	1	0.23	0.26	1.0	1.1	75
Liquid Conductivity - Temperature Uncertainty	E3.4	3.4	R	1.732	0.78	0.71	1.5	1.4	∞
Liquid Permittivity - Temperature Uncertainty	E3.4	0.6	R	1.732	0.23	0.26	0.1	0.1	∞
Liquid Conductivity - deviation from target values	E3.2	5.0	R	1.73	0.64	0.43	1.8	1.2	∞
Liquid Permittivity - deviation from target values	E3.2	5.0	R	1.73	0.60	0.49	1.7	1.4	∞
Combined Standard Uncertainty (k=1)							RSS	13.8	13.6
Expanded Uncertainty (95% CONFIDENCE LEVEL)							k=2	27.6	27.1

The above measurement uncertainties are according to IEEE Std. 1528-2013

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